



Reducing the Athena WFI Background with the Science Products Module: Lessons from Chandra ACIS

Catherine Grant, Eric Miller, Mark Bautz (MIT), Esra Bulbul, Ralph Kraft, Paul Nulsen (SAO), David Burrows (PSU), Steve Allen (Stanford)





SPM – Science Products Module

- Proposed US contribution to the WFI (MIT, SAO, PSU, Stanford)
- Secondary CPU that can perform special processing on the onboard science data stream
- MIT & SAO: Identify on-board processing algorithms that reduce and improve knowledge of the WFI particle background
 - Telemetry limitations require discarding most pixels on-board, keeping just potential X-ray event candidates
 - Additional information in the discarded full frame data may be helpful in identifying background events that are masquerading as X-ray signal events





MIT Approach: Examine On-Orbit ACIS Data

- Use unprocessed, full CCD frames from Chandra on-orbit
 - Back-Illuminated ACIS-S3 is most relevant to WFI
 - Chandra orbit samples similar environment to L2
 - $-24 \mu m$ pixels, fully depleted, 45 μm deep
 - Detector in stowed position
- Find and categorize events using on-orbit algorithms.
 - Distinguish events that would be flagged as background by standard filtering from events that are masquerading as acceptable X-ray events
- Find particle tracks (blobs) using image segmentation algorithm
- Search for phenomenological correlations that may improve background rejection





Smithsonian

Sample Chandra data Back-illuminated CCD 3.3 sec full frame 91 observations 562 total frames 2003-2016

68025 total events







Processing Frame Data



- Find particle tracks with image segmentation
 - Any contiguous set of > 4 pixels above the event threshold
 - Includes connected corners
- Perform event finding, grading, and filtering identical to ACIS on-board processing
 - No upper energy filter
 - Filter around calibration source lines of Al K, Ti K, Mn K (real X-rays)





Particle Background Time Dependence

- # of particle tracks follows secular change in solar cycle
- Variations on timescales of a day and longer







Particle Background Time Correlation

- Variations of particle rate at timescale of 3 sec frame
- ~ 20% of frames in the high count rate tail







Events and Particle Tracks Correlation

• # of rejected and *unrejected* events scales with # of particle tracks



13th IACHEC meeting





MIT Activities: Spatial Correlation

- Are valid (unrejected) events associated with particle tracks in a single frame?
- Correlate particle tracks with rejected events, valid events, and X-ray events
- Perform analysis for unbinned ACIS pixels (24 x 24 μm) and binned approximation of WFI pixels (120 x 120 μm)
 - ACIS CCD thickness is 45 μm , not 350-450 μm
 - Particle tracks in WFI will be larger!
 - WFI event processing may be different







MIT Activities: ACIS Grade Filtering

- ACIS (ASCA) grades are based on the 3x3 pixel island, and the pattern of pixels above the split threshold
- Optional filtering can be applied on ground based on any pixel in the outer 5x5 above split threshold
 - "VFAINT" filtering
 - Requires individual 5x5 pulse heights or a flag indicating which are high
 - Reduces BG by 4x at 0.3 keV, 1.25x above 6 keV (ACIS BI)









MIT Activities: Correlations with Particle Tracks 24 µm pixels (ACIS)

From combined 562 ACIS BI frames (55685 rejected; 12340 valid; 33192 X-rays)







MIT Activities: Correlations with Particle Tracks 24 µm pixels (ACIS)

From combined 562 ACIS BI frames







MIT Activities: Correlations with Particle Tracks 120 µm pixels (~WFI)

From combined 562 ACIS BI frames







MIT Activities: Correlations with Particle Tracks 120 µm pixels (~WFI)

From combined 562 ACIS BI frames







Preliminary Conclusions and Future Plans

- Clear spatial correlation between particle tracks and unrejected background events in ACIS data
- On-board particle track identification may allow reduction of WFI background
- Further work is required
 - SAO is doing a similar analysis on EPIC-pn small window mode, better analog to WFI than ACIS
 - MIT is examining Geant4 simulations of WFI particle background
 - Continue to further characterize particle tracks (image segmentation, detached secondaries)